# Some Simple High Dimensional One and Two Sample Tests

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#### Abstract

Consider testing  $H_0: \boldsymbol{\mu} = \mathbf{0}$  versus  $H_A: \boldsymbol{\mu} \neq \mathbf{0}$  using a random sample  $\boldsymbol{x}_1, ..., \boldsymbol{x}_n$ where the  $\boldsymbol{x}_i$  are  $p \times 1$  random vectors and p may be much larger than n. Several one sample tests use the same test statistic  $T_n$  with different estimators of the variance  $V(T_n)$ . Rather simple theory from U-statistics is used to find  $V(T_n)$ , resulting in an estimator that is quick to compute when  $H_0$  is true. Some two sample tests for  $H_0: \boldsymbol{\mu}_1 = \boldsymbol{\mu}_2$  are also considered.

**KEY WORDS:** Hotelling's  $T^2$  Test, Paired t Test, Subsampling, U-Statistics.

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#### **1** INTRODUCTION

Consider testing  $H_0: \mu = 0$  versus  $H_A: \mu \neq 0$  using independent and identically distributed (iid)  $\boldsymbol{x}_1, ..., \boldsymbol{x}_n$  where the  $\boldsymbol{x}_i$  are  $p \times 1$  random vectors and p may be much larger than n. Assume the expected value  $E(\boldsymbol{x}_i) = \mu$  and nonsingular covariance matrix  $Cov(\boldsymbol{x}_i) = \boldsymbol{\Sigma}$ . Replace  $\boldsymbol{x}_i$  by  $\boldsymbol{w}_i = \boldsymbol{x}_i - \boldsymbol{\mu}_0$  to test  $H_0: \boldsymbol{\mu} = \boldsymbol{\mu}_0$  versus  $H_A: \boldsymbol{\mu} \neq \boldsymbol{\mu}_0$ . This section reviews some tests while the following section gives a new test that has very simple large sample theory.

Suppose p is fixed, and consider testing  $H_0: \boldsymbol{\theta} = \boldsymbol{\theta}_0$  versus  $H_1: \boldsymbol{\theta} \neq \boldsymbol{\theta}_0$  where a  $g \times 1$  statistic  $T_n$  satisfies  $\sqrt{n}(T_n - \boldsymbol{\theta}) \xrightarrow{D} \boldsymbol{u} \sim N_g(\boldsymbol{0}, \boldsymbol{\Sigma})$ . If  $\hat{\boldsymbol{\Sigma}}^{-1} \xrightarrow{P} \boldsymbol{\Sigma}^{-1}$  and  $H_0$  is true, then

$$D_n^2 = D_{\boldsymbol{\theta}_0}^2(T_n, \hat{\boldsymbol{\Sigma}}/n) = n(T_n - \boldsymbol{\theta}_0)^T \hat{\boldsymbol{\Sigma}}^{-1}(T_n - \boldsymbol{\theta}_0) \xrightarrow{D} \boldsymbol{u}^T \boldsymbol{\Sigma}^{-1} \boldsymbol{u} \sim \chi_g^2$$

as  $n \to \infty$ . Then a Wald type test rejects  $H_0$  at significance level  $\delta$  if  $D_n^2 > \chi^2_{g,1-\delta}$  where  $P(X \leq \chi^2_{g,1-\delta}) = 1 - \delta$  if  $X \sim \chi^2_g$ , a chi-square distribution with g degrees of freedom. It is common to implement a Wald type test using

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$$D_n^2 = D_{\boldsymbol{\theta}_0}^2(T_n, \boldsymbol{C}_n/n) = n(T_n - \boldsymbol{\theta}_0)^T \boldsymbol{C}_n^{-1}(T_n - \boldsymbol{\theta}_0) \xrightarrow{D} \boldsymbol{u}^T \boldsymbol{C}^{-1} \boldsymbol{u}$$

as  $n \to \infty$  if  $H_0$  is true, where the  $g \times g$  symmetric positive definite matrix  $\mathbf{C}_n \xrightarrow{P} \mathbf{C} \neq \mathbf{\Sigma}$ . Hence  $\mathbf{C}_n$  is the wrong dispersion matrix, and  $\mathbf{u}^T \mathbf{C}^{-1} \mathbf{u}$  does not have a  $\chi_g^2$  distribution when  $H_0$  is true. Often  $\mathbf{C}_n$  is a regularized estimator of  $\mathbf{\Sigma}$ , or  $\mathbf{C}_n^{-1}$  is a regularized estimator of the precision matrix  $\mathbf{\Sigma}^{-1}$ , such as  $\mathbf{C}_n = diag(\hat{\mathbf{\Sigma}})$  or  $\mathbf{C}_n = \mathbf{I}_g$ , the  $g \times g$  identity matrix. Rajapaksha and Olive (2024) showed how to bootstrap Wald tests with the wrong dispersion matrix.

When n is much larger than p, the one sample Hotelling (1931)  $T^2$  test is often used to test  $H_0: \mu = \mu_0$  versus  $H_A: \mu \neq \mu_0$ . The sample mean

$$\overline{\boldsymbol{x}} = \frac{1}{n} \sum_{i=1}^{n} \boldsymbol{x}_i,$$

and the sample covariance matrix

$$\boldsymbol{S} = \frac{1}{n-1} \sum_{i=1}^{n} (\boldsymbol{x}_i - \overline{\boldsymbol{x}}) (\boldsymbol{x}_i - \overline{\boldsymbol{x}})^T = (S_{ij}).$$

That is, the ij entry of S is the sample covariance  $S_{ij}$ . If the  $x_i$  are iid with expected value  $E(x_i) = \mu$  and nonsingular covariance matrix  $Cov(x_i) = \Sigma$ , then by the multivariate central limit theorem

$$\sqrt{n}(\overline{\boldsymbol{x}}-\boldsymbol{\mu}) \xrightarrow{D} N_p(\boldsymbol{0},\boldsymbol{\Sigma}).$$

If  $H_0$  is true, then

$$T_H^2 = n(\overline{\boldsymbol{x}} - \boldsymbol{\mu}_0)^T \boldsymbol{S}^{-1}(\overline{\boldsymbol{x}} - \boldsymbol{\mu}_0) \xrightarrow{D} \chi_p^2.$$

The one sample Hotelling's  $T^2$  test rejects  $H_0$  if  $T_H^2 > D_{1-\delta}^2$  where  $D_{1-\delta}^2 = \chi_{p,\delta}^2$  and  $P(Y \leq \chi_{p,\delta}^2) = \delta$  if  $Y \sim \chi_p^2$ . Alternatively, use

$$D_{1-\delta}^{2} = \frac{(n-1)p}{n-p} F_{p,n-p,1-\delta}$$

where  $P(Y \leq F_{p,d,\delta}) = \delta$  if  $Y \sim F_{p,d}$ . The scaled F cutoff can be used since  $T_H^2 \xrightarrow{D} \chi_p^2$  if  $H_0$  holds, and

$$\frac{(n-1)p}{n-p}F_{p,n-p,1-\delta} \to \chi^2_{p,1-\delta}$$

as  $n \to \infty$ .

The next two high dimensional tests are described in Srivastava and Du (2008). Also see Hu and Bai (2015). Let  $tr(\mathbf{A})$  be the trace of square matrix  $\mathbf{A}$ . Let  $\mathbf{R}$  be the sample correlation matrix. Consider testing  $H_0: \boldsymbol{\mu} = \mathbf{0}$  versus  $H_A: \boldsymbol{\mu} \neq \mathbf{0}$ . Let  $\mathbf{D} = diag(\mathbf{S})$ . Let

$$c_{p,n} = 1 + \frac{tr(\mathbf{R}^2)}{p^{3/2}}.$$

Let  $n = O(p^{\delta})$  where  $0.5 < \delta \le n$ . Then under regularity conditions

$$Z_1 = \frac{n\overline{\boldsymbol{x}}^T \boldsymbol{D}^{-1}\overline{\boldsymbol{x}} - \frac{(n-1)p}{n-3}}{2\left(tr(\boldsymbol{R}^2) - \frac{p^2}{n-1}\right)} \xrightarrow{D} N(0,1)$$

as  $n, p \to \infty$ . The next test is attributed to Bai and Saranadasa (1996). Suppose  $p/n \to c > 0$ . Under regularity conditions,

$$Z_2 = \frac{n\overline{\boldsymbol{x}}^T\overline{\boldsymbol{x}} - tr(\boldsymbol{S})}{\left[\frac{2(n-1)n}{(n-2)(n+1)}\left(tr(\boldsymbol{S}^2) - \frac{1}{n}[tr(\boldsymbol{S})]^2\right)\right]^{1/2}} \xrightarrow{D} N(0,1)$$

as  $n, p \to \infty$ . Both of these test statistics need  $p/n \to c > 0$  or  $p/n^2 \to 0$ . Hence p can not be too big.

For test statistic  $T_n$ , let  $V(T_n)$  be the variance of  $T_n$  and let  $s_n^2 = \hat{V}(T_n)$  be a consistent estimator of  $T_n$ . Then there are test statistics  $T_n$  for testing  $H_0 : \boldsymbol{\mu} = \mathbf{0}$ , where p can be much larger than n, with

$$\frac{T_n}{s_n} \xrightarrow{D} N(0,1)$$

where  $T_n$  is relatively simple to compute while  $s_n$  is much harder to compute. The following test is due to Chen and Qin (2010). Also see Hu and Bai (2015). Let  $\boldsymbol{a} = \sum_{i=1}^{n} \boldsymbol{x}_i$  and let  $\boldsymbol{X} = (x_{ij})$  be the data matrix with *i*th row =  $\boldsymbol{x}_i^T$  and *ij* element =  $x_{ij}$ . Let  $vec(\boldsymbol{A})$  stack the columns of matrix  $\boldsymbol{A}$  so that  $\boldsymbol{c} = vec(\boldsymbol{X}^T) = [\boldsymbol{x}_1^T, \boldsymbol{x}_2^T, ..., \boldsymbol{x}_n^T]^T$ . Then

$$c^{T}c = \sum_{i=1}^{n} x_{i}^{T}x_{i} = \sum_{i=1}^{n} ||x_{i}||^{2} = \sum_{i=1}^{n} \sum_{j=1}^{p} (x_{ij})^{2}.$$

Let

$$T_{n} = \frac{1}{n(n-1)} [\boldsymbol{a}^{T} \boldsymbol{a} - \boldsymbol{c}^{T} \boldsymbol{c}] = \frac{1}{n(n-1)} \sum_{i \neq j} \sum_{i \neq j} \boldsymbol{x}_{i}^{T} \boldsymbol{x}_{j} = \frac{1}{n(n-1)} \sum_{i \neq j} \boldsymbol{x}_{i}^{T} \boldsymbol{x}_{j}.$$
 (1)

The terms in  $\mathbf{c}^T \mathbf{c} = \sum_{i=1}^n \mathbf{x}_i^T \mathbf{x}_i$  are the terms that cause the restriction on p for asymptotic normality for the previous two tests. Under  $H_0: \boldsymbol{\mu} = \mathbf{0}$  and additional regularity conditions,

$$\frac{T_n}{\sqrt{V(T_n)}} \xrightarrow{D} N(0,1) \text{ and } \frac{T_n}{s_n} \xrightarrow{D} N(0,1)$$
(2)

where  $s_n$  is rather hard to compute. Here

$$s_n^2 = \frac{2}{n(n-1)} tr \left[ \sum_{i \neq j} (\boldsymbol{x}_i - \overline{\boldsymbol{x}}_{(i,j)}) \boldsymbol{x}_i^T (\boldsymbol{x}_j - \overline{\boldsymbol{x}}_{(i,j)}) \boldsymbol{x}_j^T \right]$$

is a consistent estimator of  $V(T_n)$  where  $\overline{\boldsymbol{x}}_{(i,j)}$  is the sample mean computed without  $\boldsymbol{x}_i$  or  $\boldsymbol{x}_j$ :

$$\overline{\boldsymbol{x}}_{(i,j)} = rac{1}{n-2} \sum_{k \neq i,j} \boldsymbol{x}_k.$$

The  $T_n$  in Equation (1) can be viewed as a modification of  $\|\overline{\boldsymbol{x}}\|^2 = \overline{\boldsymbol{x}}^T \overline{\boldsymbol{x}}$  that is a better estimator of  $\boldsymbol{\mu}^T \boldsymbol{\mu}$  in high dimensions. Note that  $\boldsymbol{\mu} = \boldsymbol{0}$  iff  $\boldsymbol{\mu}^T \boldsymbol{\mu} = 0$  and  $E(\boldsymbol{x}_i^T \boldsymbol{x}_j) = \boldsymbol{\mu}^T \boldsymbol{\mu}$  if  $\boldsymbol{x}_i$  and  $\boldsymbol{x}_j$  are iid with  $E(\boldsymbol{x}_i) = \boldsymbol{\mu}$  and  $i \neq j$ .

As noted by Park and Ayyala (2013),  $nT_n = n\overline{x}^T\overline{x} - tr(S)$ . This result holds since

$$T_n = \frac{1}{n(n-1)} \left[ \sum_i \sum_j \boldsymbol{x}_i^T \boldsymbol{x}_j - \sum_i \boldsymbol{x}_i^T \boldsymbol{x}_i \right] = \frac{n^2 \overline{\boldsymbol{x}}^T \overline{\boldsymbol{x}} - \sum_i \boldsymbol{x}_i^T \boldsymbol{x}_i}{n(n-1)}.$$

Now

$$oldsymbol{S} = rac{1}{n-1} \left[ \sum_i oldsymbol{x}_i oldsymbol{x}_i^T - n \overline{oldsymbol{x}} \ \overline{oldsymbol{x}}^T 
ight].$$

Thus

$$tr(\boldsymbol{S}) = \frac{1}{n-1} \left[ \sum_{i} tr(\boldsymbol{x}_{i} \boldsymbol{x}_{i}^{T}) - ntr(\overline{\boldsymbol{x}} \ \overline{\boldsymbol{x}}^{T}) \right] = \frac{1}{n-1} \left[ \sum_{i} \boldsymbol{x}_{i}^{T} \boldsymbol{x}_{i} - n\overline{\boldsymbol{x}}^{T} \overline{\boldsymbol{x}} \right].$$

Thus

$$n\overline{\boldsymbol{x}}^T\overline{\boldsymbol{x}} - tr(\boldsymbol{S}) = n\overline{\boldsymbol{x}}^T\overline{\boldsymbol{x}} + \frac{n}{n-1}\overline{\boldsymbol{x}}^T\overline{\boldsymbol{x}} - \frac{1}{n-1}\sum_i \boldsymbol{x}_i^T\boldsymbol{x}_i = \frac{n^2\overline{\boldsymbol{x}}^T\overline{\boldsymbol{x}} - \sum_i \boldsymbol{x}_i^T\boldsymbol{x}_i}{n-1}$$

We will also consider replacing  $\boldsymbol{x}_i$  by  $\boldsymbol{z}_i = ss(\boldsymbol{x}_i)$  where the spatial sign function  $ss(\boldsymbol{x}_i) = \boldsymbol{0}$  if  $\boldsymbol{x}_i = \boldsymbol{0}$ , and  $ss(\boldsymbol{x}_i) = \boldsymbol{x}_i/||\boldsymbol{x}_i||$  otherwise. This function projects the nonzero  $\boldsymbol{x}_i$  onto the unit *p*-dimensional hypersphere centered at  $\boldsymbol{0}$ . Let  $T_n(\boldsymbol{w})$  denote the statistic  $T_n$  computed from an iid sample  $\boldsymbol{w}_1, ..., \boldsymbol{w}_n$ . Since the  $\boldsymbol{z}_i$  are iid if the  $\boldsymbol{x}_i$  are iid, use  $T_n(\boldsymbol{z})$  to test  $H_0 : \boldsymbol{\mu}_{\boldsymbol{z}} = \boldsymbol{0}$  versus  $H_A : \boldsymbol{\mu}_{\boldsymbol{z}} \neq \boldsymbol{0}$  where  $\boldsymbol{\mu}_{\boldsymbol{z}} = E(\boldsymbol{z}_i)$ . In general,  $\boldsymbol{\mu}_{\boldsymbol{z}} \neq \boldsymbol{\mu} = \boldsymbol{\mu}_{\boldsymbol{x}} = E(\boldsymbol{x}_i)$ , but  $\boldsymbol{\mu}_{\boldsymbol{z}} = \boldsymbol{\mu} = \boldsymbol{0}$  can occur if the  $\boldsymbol{x}_i$  have a lot of symmetry about  $\boldsymbol{0}$ . In particular,  $\boldsymbol{\mu}_{\boldsymbol{z}} = \boldsymbol{\mu} = \boldsymbol{0}$  if the  $\boldsymbol{x}_i$  are iid from an elliptically contoured distribution with center  $\boldsymbol{\mu} = \boldsymbol{0}$ . The test based on the statistic  $T_n(\boldsymbol{z})$  can be useful if the second moment of the  $\boldsymbol{x}_i$  does not exist, for example if the  $\boldsymbol{x}_i$  are iid from a multivariate Cauchy distribution. These results may be useful for understanding papers such as Wang, Peng, and Li (2015)

Section 2 finds estimators  $s_n^2$  of  $V(T_n)$  that are easier to compute, and gives a new test with very simple large sample theory. Section 3 considers two sample tests.

#### **2** Estimating $V(T_n)$

Some notation for the simple test is needed. Assume  $\boldsymbol{x}_1, ..., \boldsymbol{x}_n$  are iid,  $E(\boldsymbol{x}_i) = \boldsymbol{\mu}$  and the variance  $V(\boldsymbol{x}_i^T \boldsymbol{x}_j) = \sigma_W^2$  for  $i \neq j$ . Let  $m = \text{floor}(n/2) = \lfloor n/2 \rfloor$  be the integer part of n/2. So floor(100/2) = floor(101/2) = 50. Let the iid random variables  $W_i = \boldsymbol{x}_{2i-1}^T \boldsymbol{x}_{2i}$  for i = 1, ..., m. Hence  $W_1, W_2, ..., W_m = \boldsymbol{x}_1^T \boldsymbol{x}_2, \boldsymbol{x}_3^T \boldsymbol{x}_4, ..., \boldsymbol{x}_{2m-1}^T \boldsymbol{x}_{2m}$ . Note that  $E(W_i) = \boldsymbol{\mu}^T \boldsymbol{\mu}$  and  $V(W_i) = \sigma_W^2$ . Let  $S_W^2$  be the sample variance of the  $W_i$ :

$$S_W^2 = \frac{1}{m-1} \sum_{i=1}^m (W_i - \overline{W})^2.$$

If  $\sigma_W^2 \propto \tau^2 p$  where p > n, then n may not be large enough for the normal approximation to hold. The following theorem follows from the univariate central limit theorem.

**Theorem 1.** Assume  $\boldsymbol{x}_1, ..., \boldsymbol{x}_n$  are iid,  $E(\boldsymbol{x}_i) = \boldsymbol{\mu}$ , and the variance  $V(\boldsymbol{x}_i^T \boldsymbol{x}_j) = \sigma_W^2$  for  $i \neq j$ . Let  $W_1, ..., W_m$  be defined as above. Then a)  $\sqrt{m}(\overline{W} - \boldsymbol{\mu}^T \boldsymbol{\mu}) \xrightarrow{D} N(0, \sigma_W^2)$ .

b) 
$$\frac{\sqrt{m}(\overline{W} - \boldsymbol{\mu}^T \boldsymbol{\mu})}{S_W} \xrightarrow{D} N(0, 1)$$

as  $n \to \infty$ .

The following theorem derives  $V(T_n)$  under much simpler regularity conditions than those in the literature, and the proof of the theorem is also simple. For example, Li (2023) finds  $V(T_n)$  when  $H_0$  is true, using much stronger regularity conditions than in Theorem 2. In the simulations, we use a variant of the Li (2023) variance estimator  $\hat{\sigma}_W^2$ , and also use the estimator  $S_W^2$  that is much easier to compute.

**Theorem 2.** Assume  $\boldsymbol{x}_1, ..., \boldsymbol{x}_n$  are iid,  $E(\boldsymbol{x}_i) = \boldsymbol{\mu}$ , and the variance  $V(\boldsymbol{x}_i^T \boldsymbol{x}_j) = \sigma_W^2$  for  $i \neq j$ . Let  $W_{ij} = \boldsymbol{x}_i^T \boldsymbol{x}_j$  for  $i \neq j$ . Let  $\theta = Cov(W_{ij}, W_{id})$  where  $j \neq d, i < j$ , and i < d. Then

a) 
$$V(T_n) = \frac{2\sigma_W^2}{n(n-1)} + \frac{4(n-2)\theta}{n(n-1)}.$$

b) If  $H_0: \boldsymbol{\mu} = \boldsymbol{0}$  is true, then  $\theta = 0$  and

$$V_0 = V(T_n) = \frac{2\sigma_W^2}{n(n-1)}.$$

**Proof.** a) To find the variance  $V(T_n)$  with  $T_n$  from Equation (1), let  $W_{ij} = \boldsymbol{x}_i^T \boldsymbol{x}_j = W_{ji}$ , and note that

$$T_n = \frac{2}{n(n-1)} H_n$$
 where  $H_n = \sum_{i < j} \sum_{j} \boldsymbol{x}_i^T \boldsymbol{x}_j = \sum_{i < j} \boldsymbol{x}_i^T \boldsymbol{x}_j.$ 

Then  $V(H_n) = Cov(H_n, H_n) =$ 

$$Cov\left(\sum_{i < j} \sum_{j} W_{ij}, \sum_{k < d} \sum_{d} W_{kd}\right) = \sum_{i < j} \sum_{j} \sum_{k < d} Cov(W_{ij}, W_{kd}).$$
(3)

Let  $V(W_{ij}) = \sigma_W^2$  for  $i \neq j$ . The covariances are of 3 types. First, if (ij) = (kd) with i < j, then  $Cov(W_{ij}, W_{kd}) = V(W_{ij}) = \sigma_W^2$ . Second, if i, j, k, d are distinct with i < j and k < d, then  $W_{ij}$  and  $W_{kd}$  are independent with  $Cov(W_{ij}, W_{kd}) = 0$ . Third, there are terms where exactly three of the four subscripts are distinct, which have  $Cov(W_{ij}, W_{id}) = \theta$  where  $j \neq d$ , i < j, and i < d or  $Cov(W_{ij}, W_{kj}) = \theta$  where  $i \neq k, i < j$ , and k < j. These covariance terms are all equal to the same number  $\theta$  since  $W_{ij} = W_{ji}$ . The number of ways to get three distinct subscripts is

$$a - b - c = \binom{n}{2}^{2} - \binom{n}{2}\binom{n-2}{2} - \binom{n}{2} = n(n-1)(n-2)$$

since a is the number of terms on the right hand side of (3), b is the number of terms where i, j, k, d are distinct with i < j and k < d, and c is the number of terms where (ij) = (kd) with i < j. [Note that n(n-1) terms have i and j distinct. Half of these terms have i < j and half have i > j. Similarly, n(n-1)(n-2)(n-3) terms have ijkddistinct, and half of the n(n-1) terms have i < j, while half of the (n-2)(n-3) terms have k < d.] Thus

$$V(H_n) = 0.5n(n-1)\sigma_W^2 + n(n-1)(n-2)\theta.$$

This calculation was adapted from Lehmann (1975, pp. 336-337). Thus

$$V(T_n) = \frac{4}{[n(n-1)]^2} V(H_n) = \frac{2\sigma_W^2}{n(n-1)} + \frac{4(n-2)\theta}{n(n-1)}$$

b) Now  $\theta = Cov(\boldsymbol{x}_i^T \boldsymbol{x}_j, \boldsymbol{x}_i^T \boldsymbol{x}_j)$  where  $\boldsymbol{x}_i, \boldsymbol{x}_j$ , and  $\boldsymbol{x}_k$  are iid. Hence  $\theta =$ 

$$Cov(\sum_{d} x_{id}x_{jd}, \sum_{t} x_{it}x_{kt}) = \sum_{d} \sum_{t} Cov(x_{id}x_{jd}, x_{it}x_{kt}) = \sum_{d} \sum_{t} [E(x_{id}x_{jd}x_{it}x_{kt}] - E(x_{id}x_{jd})E(x_{it}x_{kt})] = \sum_{d} \sum_{t} [E(x_{id}x_{it})E(x_{jd})E(x_{kt})] - E(x_{id})E(x_{jd})E(x_{it})E(x_{kt})] = \sum_{d} \sum_{t} [E(x_{jd})E(x_{kt})(E(x_{id}x_{it}) - E(x_{id})E(x_{it}))] = \sum_{d} \sum_{t} [E(x_{jd})E(x_{kt})(E(x_{kt}) - E(x_{id})E(x_{it}))].$$

Under  $H_0$ ,  $\mu = 0$  and thus  $E(x_{jd}) = E(x_{kt}) = 0$ . Hence  $\theta = 0$ .  $\Box$ 

Srivastava and Du (2008), Bai and Saranadasa (1996), Chen and Qin (2010), and others use  $T_n/\sqrt{\hat{V}(T_n)} \xrightarrow{D} N(0,1)$ , while Li (2023) uses  $T_n/\sqrt{\hat{V}_0(T_n)} \xrightarrow{D} N(0,1)$ . Theorem 2 and the following result show that the second statistic has more power. Adapting an argument from Lehmann (1999, pp. 367-368), let  $Z(\mathbf{a}) = E(\mathbf{a}^T \mathbf{x}_j) = \mathbf{a}^T \boldsymbol{\mu}$ . Then it can be shown that  $\theta = V(Z(\boldsymbol{x}_i)) = V(\boldsymbol{x}_i^T \boldsymbol{\mu}) \geq 0$ . Let  $s_n^2 = \hat{V}$  be a consistent estimator of  $V(T_n)$  and let

$$\hat{V}_0 = \frac{2\hat{\sigma}_W^2}{n(n-1)}.$$

The test statistics

$$t_1 = \frac{T_n}{\sqrt{\hat{V}_0}} \xrightarrow{D} N(0,1) \text{ and } t_2 = \frac{T_n}{\sqrt{\hat{V}}} \xrightarrow{D} N(0,1)$$

if  $H_0: \boldsymbol{\mu} = \boldsymbol{0}$  is true. However, when  $H_0$  is not true,

$$\hat{V} \approx \hat{V}_0 + \frac{4(n-2)\theta}{n(n-1)}$$

where the second term is positive. If  $H_0$  is not true and n and p are such that the second term dominates, then  $|t_1|$  tends to be proportional to  $\sqrt{n}|t_2|$ , greatly increasing the power of the test that uses  $t_1$ .

For power, we expect  $V_0(T_n) \to 0$  if  $p/n^2 \to 0$  as  $n \to \infty$ . The high dimensional literature often gives very strong regularity conditions where  $V(T_n) \to 0$  if  $p^{\gamma}/n \to 0$ where  $\gamma > 0.5$  and  $\boldsymbol{\mu} = \boldsymbol{0}$ . Suppose  $\boldsymbol{\mu} = \delta \boldsymbol{1}$  where the constant  $\delta > 0$  and  $\boldsymbol{1}$  is the  $p \times 1$ vector of ones. Then  $\boldsymbol{\mu}^T \boldsymbol{\mu} = \delta^2 p$ , and the test using  $\hat{V}_0(T_n)$  may have good power for  $T_n/\sqrt{\hat{V}_0(T_n)} > 1.96 \approx 2$  or for

$$\frac{\delta^2 p}{\sqrt{\frac{2\sigma_W^2}{n(n-1)}}} > 2 \quad \text{or} \quad \delta^2 > \frac{2\sqrt{2} \sigma_W}{n p}$$

The above theory can also be applied to the  $z_i = ss(x_i)$  to test  $H_0 : E(z) = 0$ . As noted near the end of Section 1, for elliptically contoured distributions,  $E(z) = \mu_z = 0$  if  $E(x) = \mu = \mu_x = 0$ .

The nonparametric bootstrap draws a bootstrap data set  $\boldsymbol{x}_1^*, ..., \boldsymbol{x}_n^*$  with replacement from the  $\boldsymbol{x}_i$  and computes  $T_1^*$  by applying  $T_n$  on the bootstrap data set. This process is repeated B times to get a bootstrap sample  $T_1^*, ..., T_B^*$ . For the statistic  $T_n$ , the nonparametric bootstrap fails in high dimensions because terms like  $\boldsymbol{x}_j^T \boldsymbol{x}_j$  need to be avoided, and the nonparametric bootstrap has replicates: the proportion of cases in the bootstrap sample that are not replicates is about  $1 - e^1 \approx 2/3 \approx 7/11$ . The m out of n bootstrap draws a sample of size m without replacement from the n cases. For B = 1, this is a data splitting estimator, and  $T_m^* \approx N(0, s_m^2)$  for large enough m and p. Sampling without replacement is also known as subsampling and the delete d jackknife.

Theory for subsampling is given by Politis and Romano (1994) and Wu (1990). Subsampling tends to work well for a large variety of statistics if  $m/n \to 0$  with  $m \to \infty$ . A linear statistic has the form

$$\frac{1}{n}\sum_{i=1}^{n}t(U_i)$$

where  $\theta = E[t(U_i)]$  and the  $U_i$  are iid. For a linear statistic, subsampling tends to work well if  $m/n \to \tau \in [0, 1)$  with  $m \to \infty$ . For the  $W_i = U_i$  in Theorem 1,  $t(U_i) = U_i = \boldsymbol{x}_{2i-1}^T \boldsymbol{x}_{2i}$ . If different blocks were taken such that the  $W_i$  are still iid, then subsampling would still work, but the statistics from the different blocks are estimating the same quantiles. Hence subsampling from all of the data may also work well. That is, subsampling may work well for a U-statistic that is the analog of a linear statistic. Using m = floor(2n/3) worked well in simulations.

Now let  $W_i$  be an indicator random variable with  $W_i = 1$  if  $\boldsymbol{x}_i^*$  is in the sample and  $W_i = 0$ , otherwise, for i = 1, ..., n. The  $W_i$  are binary and identically distributed, but not independent. Hence  $P(W_i = 1) = m/n$ . Let  $W_{ij} = W_i W_j$  with  $i \neq j$ . Again, the  $W_{ij}$  are binary and identically distributed.  $P(W_{ij} = 1) = P(\text{ordered pair } (\boldsymbol{x}_i, \boldsymbol{x}_j))$  was selected in the sample. Hence  $P(W_{ij} = 1) = m(m-1)/[n(n-1)]$  since m(m-1) ordered pairs were selected out of n(n-1) possible ordered pairs. Then

$$T_m^* = \frac{1}{m(m-1)} \sum_{k \neq d} \boldsymbol{x}_{i_k}^T \boldsymbol{x}_{i_d} = \frac{1}{m(m-1)} \sum_{i \neq j} \sum_{k \neq j} W_i W_j \boldsymbol{x}_i^T \boldsymbol{x}_j$$

where the  $\boldsymbol{x}_{i_1}, ..., \boldsymbol{x}_{i_m}$  are the *m* vectors  $\boldsymbol{x}_i$  selected in the sample. The first double sum has m(m-1) terms while the second double sum has n(n-1) terms. Hence

$$E(T_m^*) = \frac{1}{m(m-1)} \sum \sum_{i \neq j} E[W_i W_j] \boldsymbol{x}_i^T \boldsymbol{x}_j = T_n$$

See similar calculations in Buja and Stuetzle (2006). Note that  $V(T_m^*) = E([T_m^*]^2) - [T_n]^2 = Cov(T_m^*, T_m^*).$ 

#### **3** Two Sample Tests

If  $(\boldsymbol{x}_{1i}, \boldsymbol{x}_{2i})$  come in correlated pairs, a high dimensional analog of the paired t test applies the one sample test on  $\boldsymbol{z}_i = \boldsymbol{x}_{1i} - \boldsymbol{x}_{2i}$ .

Now suppose there are two independent random samples  $\boldsymbol{x}_{1,1}, ..., \boldsymbol{x}_{n_1,1}$  and  $\boldsymbol{x}_{1,2}, ..., \boldsymbol{x}_{n_2,2}$ from two populations or groups, and that it is desired to test  $H_0 : \boldsymbol{\mu}_1 = \boldsymbol{\mu}_2$  versus  $H_1 : \boldsymbol{\mu}_1 \neq \boldsymbol{\mu}_2$  where  $E(\boldsymbol{x}_i) = \boldsymbol{\mu}_i$  are  $p \times 1$  vectors. Let  $n = n_1 + n_2$ . Let  $\boldsymbol{S}_i$  be the sample covariance matrix of  $\boldsymbol{x}_i$  and let  $Cov(\boldsymbol{x}_i) = \boldsymbol{\Sigma}_i$  for i = 1, 2.

The classical two sample Hotelling's  $T^2$  test uses

$$T_C^2 = (\overline{\boldsymbol{x}}_1 - \overline{\boldsymbol{x}}_2)^T \left[ \left( \frac{1}{n_1} + \frac{1}{n_2} \right) \hat{\boldsymbol{\Sigma}}_{pool} \right]^{-1} (\overline{\boldsymbol{x}}_1 - \overline{\boldsymbol{x}}_2)$$

where

$$\hat{\boldsymbol{\Sigma}}_{pool} = \frac{(n_1 - 1)\boldsymbol{S}_1 + (n_2 - 1)\boldsymbol{S}_2}{n - 2}.$$

Then reject  $H_0$  if  $T_C^2 > mF_{m,n-2,1-\alpha}$ .

The large sample test uses

$$T_L^2 = (\overline{\boldsymbol{x}}_1 - \overline{\boldsymbol{x}}_2)^T \left(\frac{\boldsymbol{S}_1}{n_1} + \frac{\boldsymbol{S}_2}{n_2}\right)^{-1} (\overline{\boldsymbol{x}}_1 - \overline{\boldsymbol{x}}_2).$$

Let  $d_n = \min(n_1 - p, n_2 - p)$ . Then reject  $H_0$  if  $T_L^2 > mF_{m,d_n,1-\alpha}$ .

Note that  $T_C^2 \approx T_L^2$  if  $n_1 \approx n_2 \geq 20p$  and the two tests are asymptotically equivalent if  $n_i/n \to 0.5$  as  $n_1, n_2 \to \infty$ . If the  $n_i/n$  are not close to 0.5, then the test based on  $T_C^2$ is useful if  $\Sigma_1 = \Sigma_2$ , a very strong assumption. Rajapaksha and Olive (2024) show how to get a bootstrap test based on  $T_C^2$  where the assumption  $\Sigma_1 = \Sigma_2$  is not needed.

There are test statistics  $T_n$  for testing  $H_0: \mu_1 = \mu_2$  where p can be much larger than n with

$$\frac{T_n}{s_n} \xrightarrow{D} N(0,1)$$

where  $T_n$  is relatively simple to compute while  $s_n$  is much harder to compute. A simple test takes  $m = \min(n_1, n_2)$  and  $\boldsymbol{z}_i = \boldsymbol{x}_{i1} - \boldsymbol{x}_{i2}$  for i = 1, ..., m. Then apply the one sample test from Theorem 2 to the  $\boldsymbol{z}_i$ . In low dimensions, it is known that there are better tests. In high dimensions, the power technique below Theorem 2 may be useful.

Let  $\boldsymbol{x}_1$  be the  $\boldsymbol{x}_i$  that has  $n_1 \leq n_2$ . Then let

$$oldsymbol{y}_i = oldsymbol{x}_{i1} - \sqrt{rac{n_1}{n_2}}oldsymbol{x}_{i2} + rac{1}{\sqrt{n_1 n_2}}\sum_{j=1}^{n_1}oldsymbol{x}_{j2} - \overline{oldsymbol{x}}_2 = oldsymbol{x}_{i1} - \sqrt{rac{n_1}{n_2}}oldsymbol{x}_{i2} + oldsymbol{a}_{n_1,n_2} - \overline{oldsymbol{x}}_2$$

for  $i = 1, ..., n_1$ . Note that  $\mathbf{y}_i = \mathbf{z}_i = \mathbf{x}_{i1} - \mathbf{x}_{i2}$  if  $n_1 = n_2$ . Anderson (1984, pp. 177-178) proved that  $\overline{\mathbf{y}} = \overline{\mathbf{x}}_1 - \overline{\mathbf{x}}_2$ , that  $\mathbf{y}_i$  and  $\mathbf{y}_j$  are uncorrelated for  $i \neq j$ , that  $E(\mathbf{y}_i) = \boldsymbol{\mu}_1 - \boldsymbol{\mu}_2$ , and that  $Cov(\mathbf{y}_i) = Cov(\mathbf{x}_1) + (n_1/n_2)Cov(\mathbf{x}_2)$  for  $i = 1, ..., n_1$ . Li (2023) showed that  $T_n(\mathbf{y})/\sqrt{\hat{V}_0(\mathbf{y})} \xrightarrow{D} N(0, 1)$  where the  $\mathbf{y}$  denotes that the one sample test was computed using the  $\mathbf{y}_i$ .

Let  $T_{j,n_j}$  denote the one sample test statistic applied to the  $\boldsymbol{x}_{ij}$  for j = 1, 2. Then the statistic  $T_{1n} - T_{2n}$  could be used to test  $H_0 : \boldsymbol{\mu}_1^T \boldsymbol{\mu}_1 = \boldsymbol{\mu}_2^T \boldsymbol{\mu}_2$ . However, it is possible that  $\boldsymbol{\mu}_1^T \boldsymbol{\mu}_1 = \boldsymbol{\mu}_2^T \boldsymbol{\mu}_2$  even if  $\boldsymbol{\mu}_1 \neq \boldsymbol{\mu}_2$ .

Let  $\boldsymbol{a} = \sum_{i=1}^{n_1} \boldsymbol{x}_{1i}$  and let  $\boldsymbol{X}_1 = (x_{1ij})$  be the data matrix with *i*th row  $= \boldsymbol{x}_{1i}^T$  and *ij* element  $= x_{1ij}$ . Let  $vec(\boldsymbol{A})$  stack the columns of matrix  $\boldsymbol{A}$  so that  $\boldsymbol{c} = vec(\boldsymbol{X}_1^T) = [\boldsymbol{x}_{11}^T, \boldsymbol{x}_{12}^T, ..., \boldsymbol{x}_{1n_1}^T]^T$ . Then

$$c^T c = \sum_{i=1}^{n_1} x_{1i}^T x_{1i} = \sum_{i=1}^{n_1} ||x_{1i}||^2 = \sum_{i=1}^{n_1} \sum_{j=1}^{p} (x_{1ij})^2.$$

Let  $\boldsymbol{b} = \sum_{i=1}^{n_2} \boldsymbol{x}_{2i}$  and let  $\boldsymbol{X}_2 = (x_{2ij})$  be the data matrix with *i*th row  $= \boldsymbol{x}_{2i}^T$  and *ij* element  $= x_{2ij}$ . Let  $\boldsymbol{d} = vec(\boldsymbol{X}_2^T) = [\boldsymbol{x}_{21}^T, \boldsymbol{x}_{22}^T, ..., \boldsymbol{x}_{2n_2}^T]^T$ . Then

$$d^{T}d = \sum_{i=1}^{n_{2}} x_{2i}^{T} x_{2i} = \sum_{i=1}^{n_{2}} ||x_{2i}||^{2} = \sum_{i=1}^{n_{2}} \sum_{j=1}^{p} (x_{2ij})^{2}.$$

Note that  $\|\boldsymbol{a} - \boldsymbol{b}\|^2 = \boldsymbol{a}^T \boldsymbol{a} + \boldsymbol{b}^T \boldsymbol{b} - 2\boldsymbol{a}^T \boldsymbol{a}$ , and let

$$T_n = \frac{1}{n_1(n_1 - 1)} [\boldsymbol{a}^T \boldsymbol{a} - \boldsymbol{c}^T \boldsymbol{c}] + \frac{1}{n_2(n_2 - 1)} [\boldsymbol{b}^T \boldsymbol{b} - \boldsymbol{d}^T \boldsymbol{d}] - \frac{2\boldsymbol{a}^T \boldsymbol{b}}{n_1 n_2}$$

The terms in  $\boldsymbol{c}^T \boldsymbol{c}$  and  $\boldsymbol{d}^T \boldsymbol{d}$  are the terms that cause the restriction on p for asymptotic normality. Under  $H_0: \boldsymbol{\mu}_1 = \boldsymbol{\mu}_2$  and additional regularity conditions,

$$\frac{T_n}{s_n} \xrightarrow{D} N(0,1)$$

where  $s_n$  is rather hard to compute. See Hu and Bai (2015) and Chen and Qin (2010).

## 4 SIMULATIONS

In the simulations, we examined four one sample tests. The first two tests used Theorem 2 b) and Equation 2):  $T_n/s_n \xrightarrow{D} N(0,1)$  if  $s_n^2$  is a consistent estimator of  $V(T_n)$ . The first test used  $\hat{\sigma}_W^2 = S_W^2$  based on Theorem 1. The second test used

$$\hat{\sigma}_W^2 = \frac{1}{n(n-1)} \sum_{i \neq j} (\boldsymbol{x}_i^T \boldsymbol{x}_j - T_n)^2 = \frac{1}{n(n-1)} \sum_{i \neq j} (W_{ij} - T_n)^2.$$

If the denominator n(n-1) was replaced by n(n-1)-1, this statistic would be the usual sample variance of the  $W_{ij}$ , which are not independent. This test should be asymptotically equivalent to the Li (2023) test.

These tests computed intervals

$$[T_n - t_{1-\alpha/2,m-1}\sqrt{2\hat{\sigma}_W^2/[n(n-1)]}, T_n + t_{1-\alpha/2,m-1}\sqrt{2\hat{\sigma}_W^2/[n(n-1)]}].$$

The third test computed the usual t confidence interval

$$\left[\overline{W} - t_{1-\alpha/2,m-1}S_W/\sqrt{m}, \overline{W} + t_{1-\alpha/2,m-1}S_W/\sqrt{m}\right]$$

for  $\boldsymbol{\mu}^T \boldsymbol{\mu}$  based on the  $W_i$  from Theorem 1. The fourth "test" used the *m* out of *n* bootstrap to compute  $T_1^*, ..., T_B^*$  with B = 100. We used the shorth bootstrap "confidence interval" described in Olive (2023, chapter 2) and Pelawa Watagoda and Olive (2021). All four tests rejected  $H_0$  if 0 was not in the interval. The fourth "test" is ad hoc since it has not yet been proven to have level  $\alpha$ . Since  $nT_n = n\overline{\boldsymbol{x}}^T\overline{\boldsymbol{x}} - tr(\boldsymbol{S})$ , the bootstrap test is also a competitor for the test based on  $Z_2$ . The fifth test used the Theorem 2 test applied to the spatial sign vectors with  $S_W^2$ .

The simulation used four distribution types where  $\boldsymbol{x} = \boldsymbol{A}\boldsymbol{y} + \delta \mathbf{1}$  with  $E(\boldsymbol{x}) = \delta \mathbf{1}$ where  $\mathbf{1}$  is the  $p \times 1$  vector of ones. Type 1 used  $\boldsymbol{y} \sim N_p(\mathbf{0}, \boldsymbol{I})$ , type 2 used a mixture distribution  $\boldsymbol{y} \sim 0.6N_p(\mathbf{0}, \boldsymbol{I}) + 0.4N_p(\mathbf{0}, 25\boldsymbol{I})$ , type 3 for a multivariate  $t_4$  distribution, and type 4 for a multivariate lognormal distribution where  $\boldsymbol{y} = (y_1, \dots, y_p)$  with  $w_i = \exp(Z)$ where  $Z \sim N(0, 1)$  and  $y_i = w_i - E(w_i)$  where  $E(w_i) = \exp(0.5)$ . The covariance matrix type depended on the matrix  $\boldsymbol{A}$ . Type 1 used  $\boldsymbol{A} = \boldsymbol{I}_p$ , type 2 used  $\boldsymbol{A} = diag(\sqrt{1}, \dots, \sqrt{p})$ , and type 3 used  $\boldsymbol{A} = \psi \mathbf{1} \mathbf{1}^T + (1 - \psi) \boldsymbol{I}_p$  giving  $\operatorname{cor}(x_{ij}, x_{ik}) = \rho$  for  $j \neq k$  where  $\rho = 0$ if  $\psi = 0, \rho \to 1/(c+1)$  as  $p \to \infty$  if  $\psi = 1/\sqrt{cp}$  where c > 0, and  $\rho \to 1$  as  $p \to \infty$  if  $\psi \in (0, 1)$  is a constant. We used  $\delta = 0$  and  $\delta = 1$ . The simulation used 5000 runs, the 4  $\boldsymbol{x}$  distributions, and the 3 matrices  $\boldsymbol{A}$ . For the third  $\boldsymbol{A}$ , we used  $\psi = 1/\sqrt{p}$ .

## 5 CONCLUSIONS

The test statistic  $T_n$  estimates  $\boldsymbol{\mu}^T \boldsymbol{\mu}$  and  $V(T_n)$  is easy to estimate when  $H_0 : \boldsymbol{\mu} = \mathbf{0}$  is true. Under regularity conditions when  $H_0$  is true, Li (2023) proved that  $T_n/V(T_n) \xrightarrow{D} t_k$ as  $p \to \infty$  for fixed  $n \ge 3$  where k = n(n-1)/2 - 1.

The literature for high dimensional one and two sample tests is rather large. Hu, Tong, and Genton (2024) have many references. Two sample tests that need  $\Sigma_1 = \Sigma_2$ may not work well since the assumption of equal covariance matrices rarely holds. Some high dimensional one sample tests include Chen et al. (2011), Feng and Sun (2016), Hyodo and Nishiyama (2017), Park and Ayyala (2013), Srivastava and Du (2008), Wang, Peng, and Li (2015), and Zhao (2017). Hu and Bai (2015) also describes some tests. Chakraborty and Chaudhuri (2017) suggest a method for obtaining a k-sample test of  $\mu_1 = \cdots = \mu_k$  from a one sample test statistic.

Some high dimensional two sample tests include Ahmad (2014), Chen, Li, and Zhong (2019), Feng and Sun (2015), Gregory et al. (2015), Jiang et al. (2022), Xue and Yao (2020), and Zhang et al. (2020).

Simulations were done in R. See R Core Team (2020). The collection of Olive (2023) R functions *slpack*, available from (http://parker.ad.siu.edu/Olive/slpack.txt), has some useful functions for the inference. The function *hdhot1sim* was used to simulate the four tests, while the function *hdhot1sim2* simulates the first test, which is rather fast. The function *hdhot3sim* added the test based on sample signs using the fast test. The function *hdhot2sim* simulates the two sample test which applies the fast one sample test on the  $\mathbf{z}_i = \mathbf{x}_{i1} - \mathbf{x}_{i2}$  for i = 1, ..., m and the two sample test based on subsampling with  $m_i = floor(2n_i/3)$  for i=1,2.

The spatial sign vectors have a some outlier resistance. If the predictor variables are all continuous, the *covmb2* and *ddplot5* functions are useful for detecting outliers in high dimensions. See Olive (2023,  $\oint$  1.4.3) and Olive (2017, pp. 120-123).

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